## 600V N-Channel MOSFET

## FEATURES

- Fast switching
- $100 \%$ avalanche tested
- Improved dv/dt capability


## APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

| Device Marking and Package Information |  |  |
| :--- | :--- | :--- |
| Device | Package | Marking |
| CS4N60F | TO-220F | CS4N60F |
| CS4N60P | TO-220 | CS4N60P |
| CS4N60U | TO-251 | CS4N60U |
| CS4N60D | TO-252 | CS4N60D |

Information

| Absolute Maximum Ratings $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$, unless otherwise noted |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Parameter | Symbol | Value |  |  |  | Unit |
|  |  | TO-220F | TO-220 | TO-251 | TO-252 |  |
| Drain-Source Voltage ( $\left.\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}\right)$ | $V_{\text {DSS }}$ | 600 |  |  |  | V |
| Continuous Drain Current | $\mathrm{I}_{\mathrm{D}}$ | 4 |  |  |  | A |
| Pulsed Drain Current (note1) | $\mathrm{I}_{\mathrm{DM}}$ | 16 |  |  |  | A |
| Gate-Source Voltage | $\mathrm{V}_{\text {GSS }}$ | $\pm 20$ |  |  |  | V |
| Single Pulse Avalanche Energy (note2) | $\mathrm{E}_{\text {AS }}$ | 88 |  |  |  | mJ |
| Avalanche Current (note1) | $\mathrm{I}_{\text {AS }}$ | 4.2 |  |  |  | A |
| Repetitive Avalanche Energy (note1) | $\mathrm{E}_{\text {AR }}$ | 53 |  |  |  | mJ |
| Power Dissipation ( $\mathrm{T}_{\mathrm{C}}=25{ }^{\circ} \mathrm{C}$ ) | $\mathrm{P}_{\mathrm{D}}$ | 20 | 25 |  |  | W |
| Operating Junction and Storage Temperature Range | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | $-55 \sim+150$ |  |  |  | ${ }^{\circ} \mathrm{C}$ |


| Thermal Resistance |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Parameter | Symbol | Value |  |  |  | Unit |
|  |  | TO-220F | TO-251 | TO-252 | TO-220 |  |
| Thermal Resistance, Junction-to-Case | $\mathrm{R}_{\text {thJc }}$ | 6.25 | 5 |  |  | K/W |
| Thermal Resistance, Junction-to-Ambient | $\mathrm{R}_{\text {thJA }}$ | 62.5 | 60 |  |  |  |


| Specifications $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$, unless otherwise noted |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Parameter | Symbol | Test Conditions | Value |  |  | Unit |
|  |  |  | Min. | Typ. | Max. |  |
| Static |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | $\mathrm{V}_{\text {(BR) }{ }^{\text {dss }}}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 600 | -- | -- | V |
| Zero Gate Voltage Drain Current | $\mathrm{I}_{\text {dss }}$ | $\mathrm{V}_{\mathrm{DS}}=600 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ | -- | -- | 1 | $\mu \mathrm{A}$ |
| Gate-Source Leakage | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ | -- | -- | $\pm 100$ | nA |
| Gate-Source Threshold Voltage | $\mathrm{VGS}_{\text {G(th) }}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 3.0 | -- | 4.0 | V |
| Drain-Source On-Resistance (Note3) | $\mathrm{R}_{\text {DS(on) }}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2.0 \mathrm{~A}$ | -- | 1.8 | 2.2 | $\Omega$ |
| Dynamic |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\begin{gathered} V_{G S}=0 \mathrm{~V}, \\ V_{D S}=25 \mathrm{~V} \\ f=1.0 \mathrm{MHz} \end{gathered}$ | -- | 537 | -- | pF |
| Output Capacitance | $\mathrm{C}_{\text {oss }}$ |  | -- | 55 | -- |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  | -- | 5 | -- |  |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | $\begin{gathered} \mathrm{V}_{\mathrm{DD}}=480 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=4.0 \mathrm{~A}, \\ \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \end{gathered}$ | -- | 16 | -- | nC |
| Gate-Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ |  | -- | 3 | -- |  |
| Gate-Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ |  | -- | 8 | -- |  |
| Turn-on Delay Time | $t_{\text {d(on) }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{DD}}=250 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=4.0 \mathrm{~A}, \\ \mathrm{R}_{\mathrm{G}}=25 \Omega \end{gathered}$ | -- | 36 | -- | ns |
| Turn-on Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  | -- | 15 | -- |  |
| Turn-off Delay Time | $\mathrm{t}_{\mathrm{d} \text { (fff) }}$ |  | -- | 90 | -- |  |
| Turn-off Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  | -- | 17 | -- |  |
| Drain-Source Body Diode Characteristics |  |  |  |  |  |  |
| Continuous Body Diode Current | $\mathrm{I}_{\text {S }}$ | $\mathrm{T}_{\mathrm{C}}=25{ }^{\circ} \mathrm{C}$ | -- | -- | 4 | A |
| Pulsed Diode Forward Current | $I_{\text {SM }}$ |  | -- | -- | 16 |  |
| Body Diode Voltage | $\mathrm{V}_{\text {SD }}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{SD}}=2.0 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | -- | -- | 1.4 | V |
| Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\begin{gathered} \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=4.0 \mathrm{~A}, \\ \mathrm{di}_{\mathrm{F}} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} \end{gathered}$ | -- | 510 | -- | ns |
| Reverse Recovery Charge | $\mathrm{Q}_{\text {rr }}$ |  | -- | 1.28 | -- | $\mu \mathrm{C}$ |

## Notes

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $\mathrm{L}=10.0 \mathrm{mH}, \mathrm{V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=25 \Omega$, Starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$
3. Pulse Test: Pulse width $\leq 300 \mu \mathrm{~s}$, Duty Cycle $\leq 1 \%$

Typical Characteristics $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$, unless otherwise noted

Figure 1. Output Characteristics ( $\mathrm{T}_{\mathrm{J}}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )


Figure 3. Drain Current vs. Temperature

$T_{C}$, Case Temperature (A)
Figure 5. Transfer Characteristics


Figure 2. Body Diode Forward Voltage


Figure 4. Power Dissipation vs. Temperature


Figure 6. On-Resistance vs. Temperature


Typical Characteristics $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$, unless otherwise noted

Figure 7. Capacitance


Figure 9. Transient Thermal Impedance TO-251,TO-252,TO-220


Figure 8. Gate Charge


Figure 10. Transient Thermal Impedance TO-220F


Figure A: Gate Charge Test Circuit and Waveform


Figure B: Resistive Switching Test Circuit and Waveform


Figure C: Unclamped Inductive Switching Test Circuit and Waveform


## TO-220F




## TO-251



TO-252


## CS4N60F,CS4N60P,CS4N60U,CS4N60D

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